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## **BIB DATA SHEET**

## **CONFIRMATION NO. 1656**

10/707,657  12/30/2003  RULE  APPLICANTS  James Kenneth Aragones, Clifton Park, NY;  Jeffrey William Stein, Malvern, PA;  ** CONTINUING DATA *************************  This application is a CIP of 09/682,314 08/17/2001  ** FOREIGN APPLICATIONS ************************************	SERIAL NUME				CLASS		GROUP ART UNIT			ATTORNEY DOCKET		
APPLICANTS James Kenneth Aragones, Clifton Park, NY; Jeffrey William Stein, Malvern, PA;  ***********************************	10/707,657			_	703			2123		<b>NO.</b> 61765.005012		
James Kenneth Aragones, Clifton Park, NY; Jeffrey William Stein, Malvern, PA;  ***********************************		RULE										
This application is a CIP of 09/682,314 08/17/2001  ***FOREIGN APPLICATIONS ****  ***IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 03/11/2004  Foreign Priority claimed	James Kenneth Aragones, Clifton Park, NY;											
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Foreign Priority claimed	** FOREIGN APPLICATIONS ************************************											
35 USC 119(a-d) conditions met	** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 03/11/2004											
Acknowledged Examiner's Signature Imitials NY 6 24 6  ADDRESS  General Electric Company Patrick K. Patnode GE Global Research Center, Patent Docket Room 4A59 P.O. Box 8, Bldg. K-1 Schenectady, NY 12301 UNITED STATES  TITLE  SYSTEM AND METHOD FOR MEASURING QUALITY OF BASELINE MODELING TECHNIQUES  FEES: Authority has been given in Paper No to charge/credit DEPOSIT ACCOUNT No for following:    \textstyle{\texts	35 USC 119(a-d) conditions met ☐ Yes ☑ No ☐ Met after Allowance											
General Electric Company Patrick K. Patnode GE Global Research Center, Patent Docket Room 4A59 P.O. Box 8, Bldg. K-1 Schenectady, NY 12301 UNITED STATES  TITLE  SYSTEM AND METHOD FOR MEASURING QUALITY OF BASELINE MODELING TECHNIQUES  FILING FEE RECEIVED 1230  FEES: Authority has been given in Paper No to charge/credit DEPOSIT ACCOUNT No for following:  Quality OF BASELINE MODELING TECHNIQUES  Quality OF BASELINE MODELING TECHNIQUE					NY		6	24		6		
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FILING FEE RECEIVED 1230  SYSTEM AND METHOD FOR MEASURING QUALITY OF BASELINE MODELING TECHNIQUES    All Fees     1.16 Fees (Filing)     1.17 Fees (Processing Ext. of time)     1.18 Fees (Issue)     Other	Patrick K. Patnode GE Global Research Center, Patent Docket Room 4A59 P.O. Box 8, Bldg. K-1 Schenectady, NY 12301											
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